Precise half-life measurement of the superallowed emitter ³⁰S

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We have measured the half-life of 30 S, the parent of a superallowed $0^+ \to 0^+ \beta$ transition, to a high precision using very pure sources and a 4π proportional gas counter to detect the decay positrons. Our result for the half-life is 1.179 92(34) s. As a by-product of this measurement, we determine the half-life of its daughter, ³⁰P, to be 2.501(2) min.

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I. INTRODUCTION

Currently, the superallowed β -decay branch from 30 S is not one of the 14 $0^+ \rightarrow 0^+$ transitions that have been measured to $\pm 0.1\%$ precision and collectively used to determine, $V_{\rm ud}$, the up-down element of the Cabibbo-Kobayashi-Maskawa quark-mixing matrix. The most recent survey of world data [1] gives ft = 3005(41) s for the ³⁰S superallowed transition, a precision of $\pm 1.4\%$, which is more than a factor of 10 too large for it to contribute to any fundamental tests of the weak interaction or of isospin symmetry breaking. There are good reasons to improve this situation, though, and we report here the first step in doing so.

The superallowed $0^+ \rightarrow 0^+ \beta$ transitions between T = 1analog states are interesting in general because they depend uniquely on the vector part of the weak interaction. Their experimental ft values are related to the vector coupling constant $G_{\rm V}$, which, according to conservation of the vector current, should be the same for all such transitions. In practice, several small (\sim 1%) correction terms intervene, so these can be combined with the ft value to obtain a "corrected" $\mathcal{F}t$

$$\mathcal{F}t \equiv ft(1 + \delta_R')(1 + \delta_{\rm NS} - \delta_C) = \frac{K}{2G_{\rm V}^2(1 + \Delta_{\rm R}^{\rm V})}, \quad (1)$$

where $K/(\hbar c)^6 = 2\pi^3 \hbar \ln 2/(m_e c^2)^5 = 8120.2776(9) \times$ $10^{-10} \text{ GeV}^{-4} \text{ s}$, δ_C is the isospin-symmetry-breaking correction, and Δ_R^V is the transition-independent part of the radiative correction. The terms δ_R' and δ_{NS} comprise the transition-dependent part of the radiative correction, the former being a function only of the positron's energy and the Z of the daughter nucleus, while the latter, like δ_C , depends in its evaluation on the details of nuclear structure. This $\mathcal{F}t$ value, which combines the experimental ft together with small calculated corrections, is inversely proportional to $G_{\rm v}^2$ and thus should be statistically constant from one transition to another. The precisely determined $\mathcal{F}t$ values from 14 superallowed transitions satisfy this condition. Thus their

average can be used to derive the value of $V_{\rm ud}$ [1]. At the present time, this is the most precise result for $V_{\rm ud}$ and it enables the most demanding available test of the unitarity of the Cabibbo-Kobayashi-Maskawa matrix, a test which is passed within $\pm 0.06\%$.

Since any deviation from unitarity would be a signal of new physics, there is strong motivation to further improve the unitarity test by reducing the uncertainty attached to $V_{\rm ud}$. The largest contributor to its uncertainty is the calculated radiative correction Δ_{R}^{V} , but the nuclear-structure-dependent corrections $(\delta_C - \delta_{\rm NS})$ are the second largest [1], and unlike $\Delta_{\rm R}^{\rm V}$, they can be tested by experiment. By requiring that a set of structuredependent corrections must produce a statistically consistent set of $\mathcal{F}t$ values or be rejected, we can restrict the number of acceptable sets and, thus, reduce the uncertainties attached to $(\delta_C - \delta_{NS})$ [2].

The ³⁰S case is a particularly interesting one because its nuclear-structure-dependent correction as calculated with the currently favored "shell-model, Woods-Saxon" (SM-WS) model [1,3] is $(\delta_C - \delta_{NS}) = 1.040(32)\%$. That makes it one of the two largest correction terms among all the superallowed transitions with $A \leq 54$, the cases for which the shell model can be considered rather reliable. If the measured ft value for a transition with such a relatively large correction were to yield an $\mathcal{F}t$ value that is consistent with the other well-known cases, it would serve to verify the calculations' reliability for all those cases that have smaller corrections.

The ft value that characterizes any β transition depends on three measured quantities: the total transition energy $Q_{\rm EC}$, the half-life $t_{1/2}$ of the parent state, and the branching ratio R for the particular transition of interest. For the ³⁰S superallowed transition, only the $Q_{\rm EC}$ value can be considered known with sufficient precision. Its contribution to the ft-value uncertainty is merely $\pm 0.03\%$ [1]. The large uncertainty currently assigned to the 30 S ft value is mostly attributable to the branching ratio of the superallowed transition, which is based on a single 1963 measurement [4]. Though the half-life is known much more precisely, it is still not adequate since its world-average value [1] is quoted to $\pm 0.14\%$ and is based on only two measurements, one quoted to $\pm 0.41\%$ [5] and the other to $\pm 0.14\%$ [6].

We have chosen to begin with a measurement of the half-life of ³⁰S. Quite apart from its ultimate benefit in contributing to

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a usefully precise ft value, the measurement also offers an excellent opportunity for us to verify one of the techniques we have used in previous half-life measurements. Unlike most $T_Z = -1$ superallowed β emitters, ³⁰S does not feed a second $0^+ \rightarrow 0^+ \beta$ transition from its daughter, ³⁰P. Instead, the 0^+ , T = 1 state populated in 30 P decays electromagnetically to the 1^+ , T=0 ground state, which proceeds by ordinary allowed β decay to ³⁰Si with a half-life of 2.498(4) min [7,8]. This leads to a very clean separation between the ³⁰S half-life of 1.18 s and that of its daughter, which is more than a factor of 100 longer. In the $T_Z = -1$ cases we have measured before [9–11], the parent and daughter half-lives differ by only a factor of \sim 2, and because we detect the positrons from both decays together in the same detector, we must use the parent-daughter linkage as input to the fit in order to extract the parent half-life with any precision. This requires us to know the time dependence of the source deposit rate and also to incorporate the subtle difference between the parent and the daughter detection efficiencies for positrons [10]; together, these effects can introduce systematic uncertainties. In the case of ³⁰S, the large difference between parent and daughter half-lives makes it possible to extract a result for ³⁰S by treating the two decays as independent components and to compare that half-life result to the one obtained when the linkage between parent and daughter is enforced. This is our first opportunity to make such a comparison.

II. EXPERIMENT

A. Overview

We produced a 30S radioactive beam via the inversekinematics reaction ${}^{1}H({}^{31}P, 2n){}^{30}S$, initiated by a 30A-MeV, \sim 250-nA beam of ³¹P from the K500 superconducting cyclotron at Texas A&M University. The target was hydrogen gas at a pressure of 2 atm, contained in a cell that was kept at liquid-nitrogen temperature to increase the gas density. The fully stripped reaction products exiting the target cell entered the momentum achromat recoil spectrometer (MARS) [12], where they were separated according to their charge-to-mass ratio q/m, with 30 S being selected in the focal plane. After passing through the extraction slits, the ³⁰S beam exited the vacuum system through a 51-μm-thick Kapton window and passed through a 0.3-mm-thick BC404 scintillator, where the ions were counted, and then through a stack of aluminum degraders, finally stopping in the 76- μ m-thick aluminized Mylar tape of a fast tape-transport system.

After the radioactive sample had been collected for a time interval approximately equal to the 30 S half-life, the beam was turned off and the tape-transport system moved the sample rapidly to a well-shielded location 90 cm away, stopping it at the center of a 4π proportional gas counter. Beginning 220 ms after the beam was turned off, the decay positrons were recorded for 20 half-lives (24 s). The beam was then turned on again and the cycle repeated. These collect-move-detect cycles were controlled by the tape-transport system's precision clock, and the timing of the generated control signals was continuously monitored online by our data-acquisition system. The cycles were repeated until the desired counting statistics

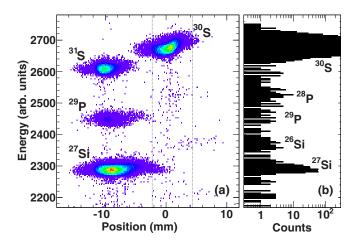


FIG. 1. Deposited energy versus position as recorded in the PSSD at the MARS focal plane. This result was obtained after the spectrometer had been tuned for ³⁰S but before the extraction slits had been narrowed. Vertical lines show the final position of the extraction slits, 6.6 mm apart, which we used during these measurements. The projection on the right is of the counts between the slits. From such spectra recorded periodically during our experiment, we determined that the extracted ³⁰S beam included a 0.37(8)% contribution from ²⁷Si and 0.050(15)% from ²⁹P.

had been achieved. For this experiment we accumulated data from nearly 6000 cycles divided into 33 separate runs, which yielded a total of 1.4×10^8 beta counts.

B. Source purity

Before beginning the measurements, we inserted a 1-mmthick 16-strip position-sensitive silicon detector (PSSD) into the focal plane of MARS while using a low-current primary beam. This detector was used first to identify the secondary reaction products and then to monitor the selection and focus of ³⁰S in the center of the beam line. As shown in Fig. 1, in addition to 30 S, there were four reaction products, 26 Si $(t_{1/2} = 2.255 \text{ s})$, 27 Si $(t_{1/2} = 4.135 \text{ s})$, 28 P $(t_{1/2} = 270.3 \text{ ms})$, and 29 P $(t_{1/2} = 4.140 \text{ s})$, that appeared between the extraction slits as weak contaminants in the extracted ³⁰S beam. On the one hand, ²⁶Si and ²⁸P were not problematic since both passed completely through the tape without contaminating the collected sample. On the other hand, ²⁷Si and ²⁹P, having a similar range to ³⁰S, were potentially a concern. With the focal-plane acceptance slits of MARS set to a width of 6.6 mm, the total extracted beam contained 0.37(8)% ²⁷Si ions and 0.050(15)% ²⁹P. The composition of the beam exiting MARS was checked on a daily basis during our half-life measurement: On each occasion we reinserted the PSSD at the MARS focal plane and acquired a spectrum equivalent to the one shown in Fig. 1. There were some changes observed from time to time in the extracted beam composition; these are reflected in the uncertainties we quote on the impurity percentages.

Although the amount of ²⁷Si contaminant from MARS, at 0.37(8)%, is already quite small, it is large enough to cause concern for a half-life measurement aiming for sub-0.1% precision, so we adjusted the thickness of the aluminum

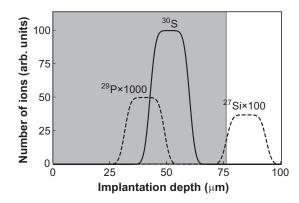


FIG. 2. Implantation profiles of ³⁰S (solid line) and the two contaminant activities, ²⁹P and ²⁷Si (dashed lines). The beam enters from the left. The shaded region shows the actual thickness of the Mylar collection tape. Our collected source contains only those ions that are stopped inside the tape.

degraders to minimize the amount of ²⁷Si that stopped in the tape. This was accomplished as follows.

Before the main measurements began, we measured the amount of ³⁰S activity retained in the tape as a function of the degrader thickness, spanning the full range from a minimum, at which all the ³⁰S passed entirely through the tape, to a maximum, at which no ³⁰S reached the tape at all. This yielded a detailed picture of the depth distribution of the implanted ions, valid not only for ³⁰S but also for other ions of similar range. It also produced an experimental value for the degrader thickness required to center the deposit at the desired depth in the tape. As in our previous published measurements, the value obtained was very close to that predicted by the SRIM code [13], giving confidence that the SRIM calculations can be relied on to determine the spatial distributions of impurities relative to that of ³⁰S.

Figure 2 presents the results of calculations based both on the SRIM code and on our measured depth distribution. Note that they correspond to the thickness of degraders we actually used in our half-life measurement, which placed the 30 S activity towards the back of the tape. The solid line in the figure represents a simplified functional form for the implantation-depth distribution of 30 S; it is consistent with the results of our scan of 30 S activity versus degrader thickness and with the known momentum spread as set by the momentum-selection slits in MARS ($\Delta p/p = 0.86\%$). We have then reproduced the semiempirical 30 S shape as dashed lines to represent the distributions of 29 P and 27 Si at their calculated locations and with their measured relative intensities.

Based on the results illustrated in Fig. 2, we determined that only approximately 4% of the ²⁷Si impurity observed in the MARS focal plane was actually retained in the tape with our particular choice of degrader thickness. This means that its effective contribution to the measurement is 0.015(15)% relative to that of ³⁰S. The contribution of ²⁹P, being obviously unaffected by the degrader choice, is the same in the tape as it was in the MARS focal plane. Coincidentally, ²⁹P and ²⁷Si have almost-identical half-lives so their effects on the measurement

are equivalent. Their relative intensities in the tape sum to 0.065(21)%, a manageably small amount.

C. 4π gas counter

Our 4π gas counter consists of two separate gas cells that, when assembled, leave a very narrow slot between them, through which the aluminized Mylar transport tape passes. The identical cells each have an active gas volume of about $30\,\mathrm{cm}^3$. They were machined from copper and are equipped with anodes of $13-\mu\mathrm{m}$ -diameter gold-plated tungsten wire. Methane at just over 1-atm pressure is continuously flushed through both cells. Methane offers adequate gas gain for detecting positrons and is quite insensitive to γ radiation. A Havar foil window, 3.7 cm in diameter and 1.5 $\mu\mathrm{m}$ thick, hermetically seals each gas cell on the side facing the tape. The performance of this type of detector is well known [14–16] and the particular detector employed in this measurement is the same one used by us in many previous half-life measurements (e.g., see Refs. [9–11,17]).

Before and after our experiments, we check the performance of the gas counter using a 90 Sr/ 90 Y β source. This source has been specially prepared on a sample length of transport tape and is inserted into the gas counter in exactly the position that an online sample occupies. We record the count rate as a function of the applied counter bias voltage. Initially, as the voltage increases the rate rises too since the increasing gas gain leads to more primary ionizing β events producing a large enough signal to be recorded. However, at approximately 2600 V a "plateau" is reached and the count rate remains nearly unchanged for the next 200–300 V increase in the bias voltage. At higher voltages still, there is a second rapid rise in count rate as spurious pulses and electronic noise are increasingly recorded. This behavior is well understood [14] and clearly demonstrates that, when operated in the plateau region, such detectors have essentially 100% efficiency with minimal rate dependence. During our ³⁰S measurements, we operated the gas counter between 2650 and 2850 V, well within the plateau region as determined with our source measurements before and after the experiment.

D. Source positioning

Although the tape transport system is quite consistent in placing the collected source within ± 3 mm of the center of the detector, it is a mechanical device and occasionally larger deviations occur. So, during the collection period of each cycle we recorded the number of ions passing through the scintillator en route to implantation; then during the subsequent count period we recorded the number of positrons detected in the gas counter. The ratio of the latter to the former is a sensitive measure of whether the source was seriously misplaced in the counter. We rejected the results from any cycle with an anomalous (i.e., low) ratio.

E. Data acquisition

Data from this measurement were acquired with essentially the same analog electronics we have used in previous measurements; a detailed description of the setup appears in Ref. [9]. Briefly, the strongly amplified signals from the gas counter are fed to a low-threshold discriminator, the output of which is split and sent to two fixed-width nonretriggering and nonextending gate generators, which introduce well-known fixed dead times that are selected to be longer than any upstream dead-time contributions. The outputs from the two gate generators are sent to two multichannel scalers, each with 15 000 channels. The time base for the acquired spectra is defined by a Stanford Research System pulser, which is accurate to 0.01 ppm.

We set the widths of the two gate generators (dead times) to be different from one another and frequently changed them—as well as the detector bias voltage and discriminator level—from run to run as a check on any systematic effects that might arise from these adjustable parameters. We monitored both gates continuously during every run by recording coincidences between each gate and 4-ns-wide pulses from a precise 1-MHz pulse generator; this gave us a continuous measure of the imposed dead times. In this experiment we used dead times of 3 and 6 μ s in dead-time channel A and 6 and 4 μ s in channel B.

We also tested for any systematic count-rate dependence in our system. Within a given run the initial β counting rate was reasonably consistent from cycle to cycle. However, we varied the 30 S production rate so that some runs were recorded at relatively high rates, while others were at considerably lower rates. Since 30 S was available in copious quantities, we covered initial rates from 7 to 20×10^3 cps (counts per second).

For the first time, in this experiment we added another parallel data-acquisition branch to our analog system. The discriminator output signal was also sent to a multichannel time-to-digital converter, which was used to record the arrival times of the β signals. Recorded, in addition, were the arrival times of the $^{30}\mathrm{S}$ ions detected by the scintillator located just in front of the collection tape; and the logic signals that originated from the tape-transport control system, indicating the start of the collect, move, and detect periods. Altogether, this information provided a decay spectrum and an independent measure of the time between collection and detection for each cycle. In this sense, it served as a parallel backup to our conventional equipment.

Beyond that, though, during analysis we could insert digitally into the time-stamp data stream from the time-to-digital converter-based system, via software, any kind or amount of dead time we chose. We could then analyze the resulting decay histogram, making our usual dead-time correction but based on the dead time we inserted digitally. The results in all cases were found to agree closely with those from our conventional analysis, so they are not referred to again.

III. ANALYSIS AND RESULTS

A. Data processing

Before analysis, we preselected the data based on two criteria. First, a cycle was rejected if the total number of β particles detected by the gas counter was less than 500, which indicates that there was little or no primary beam from the cyclotron during the collection period. This happened infrequently, so only 1.4% of the cycles were eliminated by

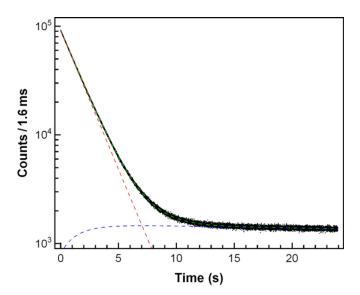


FIG. 3. Measured time-decay spectrum for the total of all data obtained from the combined β decays of 30 S and its daughter 30 P. There are 15 000 data points spanning 24 s. Dashed lines show the separate contributions calculated for the parent and daughter decays. The constant background is off scale at 7.3 counts/1.6 ms, more than four orders of magnitude less than the initial source counting rate. Note that counting began about 220 ms after the beam was turned off.

this criterion. Second, we excluded cycles based on the ratio of detected positrons to implanted sulfur ions; a low ratio indicates that the implanted source was not centrally located in the gas counter for that cycle (see Sec. II D). To be safe, for our final analysis of the data we set very tight limits on this ratio, requiring it to be between 95% and 100% of the maximum value obtained. This eliminated 15.2% of the total cycles. A separate analysis with limits offset at 91%–98% yielded a half-life that agreed with the one we obtained using our tight central limits to within their $\pm 0.02\%$ statistical uncertainties, thus confirming the validity of the latter result.

The remaining data were then corrected cycle by cycle for dead-time losses. We used the conventional method, increasing the number of events in each channel in the decay spectrum analytically for the known dominant dead time; this method is described, for example, in Ref. [16].

In this measurement, we also added a further refinement: We corrected the data for the slight dependence of detection efficiency on counting rate. This occurs because, even when the detector is operated in the "plateau" region (see Sec. II C), there is a very slight increase in efficiency with bias voltage. As the counting rate decreases during a decay measurement, the current decreases across the series resistor that connects the anode wire to the bias supply, and the effective bias on the wire increases, thus increasing the efficiency very slightly. The details of our implementation of this correction will be described separately [18]. Its impact on our final half-life turned out to be less than 0.02%, a small but nonnegligible amount.

The final decay spectrum for each run was then obtained from the sum of the dead-time- and efficiency-corrected decay spectra for all accepted cycles in that run. To illustrate the overall quality of the data, we present in Fig. 3 the total timedecay spectrum obtained by combining all the runs. Note that the daughter activity is entirely due to the decay of the $^{30}\mathrm{S}$ parent and, at its maximum, is a factor of $\sim \! 70$ less than the initial $^{30}\mathrm{S}$ activity. The constant background is another two orders of magnitude below that.

B. Half-life determination

We fitted the data from each of the 33 runs separately, incorporating five components: ³⁰S, its daughter ³⁰P, the impurities ²⁹P and ²⁷Si, and a constant background. The half-life of ³⁰P was fixed at its known value of 2.498(4) min [7] and the half-lives of ²⁹P and ²⁷Si were fixed at 4.140(16) and 4.135(19) s [19], respectively. As explained in Sec. IIB, the initial activities of ²⁹P and ²⁷Si relative to that of ³⁰S were set at 0.050(15)% and 0.015(15)%, respectively. Finally, the background was fixed to the value obtained (~1 cps) from a measurement in which all conditions were identical to those for a normal run except that the tape motion was disabled.

Note that in our primary analysis we treat 30S and its daughter ³⁰P as independent decay components. Since all the ³⁰P in our decay spectrum originates from the decay of ³⁰S, there is a well-defined connection between their intensities; and indeed, as explained in Sec. I, we have previously used such parent-daughter connections in fits when the parent and daughter half-lives are so similar that the two components are not clearly separated in the decay spectrum [9-11]. In the present case, however, the half-life of ³⁰P is more than 100 times longer than that of ³⁰S, so there is no need to connect the two activities; and we deemed that by ignoring the connection we would reduce our potential exposure to systematic uncertainties. It is the result of this procedure that we quote as our final result. However, we also performed a parallel analysis in which the parent-daughter linkage was enforced in the fits. By comparing the results from the two methods, we can test the efficacy of the latter, which was the only method available to us in previous measurements of $T_Z = -1$ superallowed β emitters.

As explained in Sec. IIE, the initial counting rate associated with each run ranged from 7 to 20×10^3 cps. We therefore chose to analyze the runs in several ways: First, we accepted all the data from each run, regardless of its rate, and obtained a half-life value by averaging the fitted results from all 33 runs. Next, we set a maximum limit of 9×10^3 cps and only analyzed that part of each run's decay spectrum for which the count rate had dropped below 9×10^3 cps; if the run had a lower rate to start with, we used its full decay spectrum. Finally, we set lower rate limits—at 7, 5, 3, and 1×10^3 cps—and repeated the analysis for each one. The half-life results for the different rate limits are given in Fig. 4; the values for dead-time channels A and B are plotted separately, although they agree very closely with one another.

It is evident from Fig. 4 that there is no significant change in the half-life result as the rate is substantially decreased. In the past, we have routinely made measurements at rates only up to 9×10^3 cps and have found no rate-dependent effects in our data-acquisition system. Although the results in the figure indicate that the inclusion of higher-rate data causes very little change, we have chosen to conservatively select the data set in

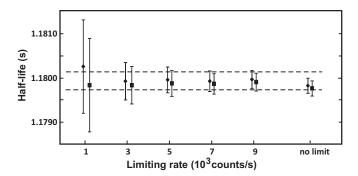


FIG. 4. Test for any systematic dependence of our evaluated 30 S half-life on the initial counting rate. Each symbol represents the average half-life from all 33 runs as obtained from only the portion of each decay spectrum that has a counting rate below a specified value. Diamonds are taken from dead-time channel A; squares, from channel B. Dashed lines give the 1σ uncertainty limits (statistical only), which correspond to the limiting rate of 9×10^3 cps. Note that the results are strongly correlated since the plotted symbols are derived from overlapping subsets of the same data.

which the rate is limited to 9×10^3 cps as our standard, and the uncertainty limits on its half-life value appear as dashed lines in the figure.

Since each run was executed with a different combination of detection settings—bias voltage, discriminator threshold setting, and dominant dead time—we could use the fitted half-lives of 30 S from each individual run to test for any systematic dependence on those settings. Employing the data set that has been limited to a maximum rate of 9×10^3 cps, we present the results for dead-time channel A in Fig. 5. Panels (a)–(c) each include all 33 runs, but the runs are grouped differently in each part, according to the parameter being investigated. No statistically significant dependence on any of the three detection settings is apparent in the figure, and this observation applies equally well to the results from dead-time channel B and from the data sets with other count-rate limits.

Our last systematic check was to test for any unanticipated short-lived impurities in the collected samples. For this purpose we needed to return to the complete rate-unlimited data set since, to be effective, this test requires that all decay spectra begin immediately after the source arrives at the counting location. With this set, we removed data from the first 0.8 s of the counting period and fitted the remaining data, then we removed an additional 0.8 s of data and fitted again. This procedure was continued until 4.0 s of data—3.4 half-lives of ³⁰S—had been removed. The result is given in Fig. 6, where, as before, we have used the data from dead-time channel A; the results from channel B show the same behavior. Evidently the half-lives obtained in this way are consistent with one another within statistical uncertainties, ruling out any shortlived impurities. This test is also sensitive to any rate-dependent effects on the half-life measurement. In agreement with the more sensitive test illustrated in Fig. 4, this test shows no sign of rate dependence.

As explained in the context of Fig. 4, we take our final half-life result from the data set limited to 9×10^3 cps, which is illustrated run by run in Fig. 5. Our final average value for

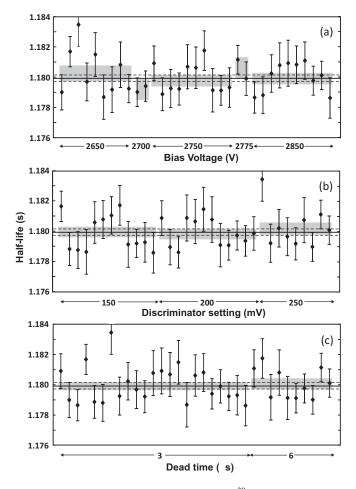


FIG. 5. Test for any systematic bias in the ^{30}S half-life measurement due to changes in three detection parameters. Shown are the results from dead-time channel A for (a) five detector biases, (b) three discriminator threshold settings, and (c) two imposed dead times. Each graph includes half-life results from all 33 runs but the runs have been grouped differently for each graph. In all cases, gray bands represent the $\pm\sigma$ limits of the average half-life for a given condition. The average value for all the runs is represented by the solid horizontal line in each graph, with the corresponding dashed lines showing the statistical uncertainty limits. The value of the reduced χ^2 for the 33-point average is 0.93.

the 30 S half-life, incorporating results from both dead-time channels, is 1.179 92(20) s, with a reduced χ^2 of 0.93. At this stage, the uncertainty is purely statistical.

With systematic instrumental effects eliminated as significant contributors to the half-life uncertainty, we must still take account of uncertainties arising from the known impurities in the collected samples and from the half-life of ³⁰P, the radioactive daughter of ³⁰S, which is a growing presence in each decay spectrum. The final error budget for the ³⁰S half-life is reported in Table I. In this measurement, it is the uncertainty associated with the two weak impurities that is the largest contributor to the overall uncertainty, although the counting statistics makes the second-largest contribution. Our final result for the ³⁰S half-life is 1.179 92(34) s, in which statistical and systematic uncertainties have been combined.

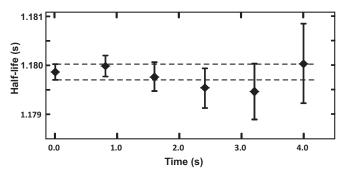


FIG. 6. Test for any systematic bias in the 30 S half-life results due to otherwise undetected short-lived impurities. Each symbol is the result of a separate fit to the data from dead-time channel A; the abscissa for each symbol represents the time period at the beginning of the counting cycle for which the data were omitted from that particular fit. Dashed lines correspond to the 1σ uncertainty limits for the full data set. Note that, unlike Fig. 5, this figure uses data without any counting-rate limits applied (see text).

C. Comparison with previous results

Although several measurements of the ³⁰S half-life have been reported previously, only two have small enough uncertainties to be relevant here. These are listed in the most recent review of $0^+ \rightarrow 0^+$ world data [1]: 1.1783(48) s [5] and 1.1759(17) s [6]. The first of these results was published more than 35 years ago: The authors used a pneumatic shuttle to transport collected samples to a Ge(Li) detector, where 16 successive β -delayed γ -ray spectra were recorded; the half-life was extracted from the decay of the 677-keV peak, the strongest one in the spectrum; this procedure uniquely isolated the decay of ³⁰S. The second, more recent measurement employed a pulsed beam and a "close-to- 4π " plastic scintillator to detect β particles; both ³⁰S and its daughter were produced directly so the decay spectra, which included both activities, contained a relatively large contribution from the latter. The results from these two previous measurements appear in Fig. 7, together with our new result.

With $\pm 0.029\%$ precision, our result is five times more precise than the most competitive previous measurement. It agrees with one of the earlier results [5] but differs from the other [6] by more than two of the latter's standard deviations. There is no obvious nonstatistical explanation for this difference, although we note that the ratio of $^{30}\text{P-to-}^{30}\text{S}$ activity in their spectra was 10 times worse (i.e., higher) than that in our spectra. The inclusion of the result from Ref. [6] in an overall average leads to a normalized χ^2 of 2.7 and an average half-life for ^{30}S of

TABLE I. Error budget for our ³⁰S half-life measurement.

Source	Uncertainty (ms)
Sample impurities (²⁹ P, ²⁷ Si)	0.27
³⁰ P half-life	0.016
Total	0.34
³⁰ S half-life result	1.179 92(34) s

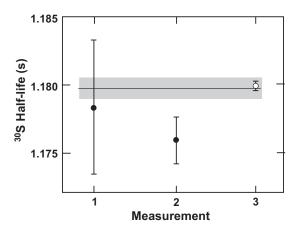


FIG. 7. The present measurement (open circle) is compared with the only two previous measurements [5,6] with subpercentage precision (filled circles). Results are presented in chronological order from left to right. The $\pm \sigma$ limits on the overall average value of 1.179 76(77) s appear as the gray band. Note that the uncertainty of the average has been scaled by a factor of 2.3 as a result of the inconsistency between measurement 2 and measurement 3 (see text).

1.179 76(77) s, a result that includes an uncertainty scale factor (see Ref. [1]) of 2.3.

D. Half-life of ³⁰P

In the midst of our measurement of the half-life of ³⁰S, we changed the time sequencing of our collect-move-count cycles in order to focus on the decay of its daughter, ³⁰P. Although the latter's half-life plays a minor role in the analysis of the ³⁰S decay, we wanted to be sure that the accepted half-life for ³⁰P was not seriously incorrect. With 30-s collect and 60-s detect periods we accumulated ~2 million counts in eight complete cycles.

These data were analyzed in the manner described in Sec. III B except that in this case the half-life of ³⁰S was fixed at our measured value and the half-life of ³⁰P was determined from the fit. The result we obtained for the half-life of ³⁰P was 2.501(2) min, which is more precise than, but completely consistent with, the literature value of 2.498(4) min [7].

E. Test of analysis with parent-daughter link

All the results quoted so far were arrived at by our considering the 30 S and 30 P activities to be independent of one another. We have already explained that this is the optimum approach for parent and daughter activities with very different half-lives, but the same approach cannot be taken when the activities have similar half-lives, as was the case for the $T_Z = -1$ superallowed emitters we have studied previously. As a test of the method we were forced to use in those cases, we have

also analyzed the mass-30 data by fitting the decay spectra with the parent and daughter decays linked. In doing so, we used our measured record of source deposition as a function of time and the calculated difference in detection efficiencies for the parent and daughter activities, just as we did in our previous measurements [9–11].

The result we obtain for the 30 S half-life that way is 1.179 86(20) s, where the uncertainty is statistical only. It agrees very closely with the result we quote in Sec. IIIB, where we have omitted the linkage between the parent and the daughter activities, and the $\pm 0.017\%$ uncertainties are the same. This convincingly validates the method we have used in the past to determine precise half-lives for $T_Z=-1$ superallowed emitters.

IV. CONCLUSIONS

We have measured the half-life of 30 S to be 1.179 92(34) s. This is a factor of 5 more precise than the currently accepted value [1] and, at $\pm 0.029\%$, is more than sufficient to allow the 30 S superallowed ft value to contribute to the evaluation of $V_{\rm nd}$ once the branching ratio has been measured with sufficient precision. Unfortunately, though, one of the previous half-life measurements [6] disagrees by two of its standard deviations from our more precise result, thus degrading the precision attributable to the world-average value. Using the methods employed in the periodic surveys of world data for superallowed decays (e.g., see Ref. [1]), we obtain an average half-life value of 1.17976(77) s. Although this scaled-up uncertainty ($\pm 0.065\%$) is still an improvement over the previously accepted average, it cries out for yet another measurement with sufficient precision (and accuracy) to resolve the disagreement now revealed between the two most recent measurements.

Because the 30 S and 30 P half-lives differed by more than a factor of 100, we could analyze our data either by treating the parent and daughter activities as being independent of one another or by enforcing the linkage between them. Thus, we could test the efficacy of the latter method, which is the one we have been forced to use exclusively in previous half-life measurements of $T_Z = -1$ superallowed emitters, since in those cases the parent and daughter half-lives differed by merely a factor of 2. The results with both methods were consistent well within their $\pm 0.017\%$ precision.

Finally, as a by-product of this measurement, we have measured the half-life of ³⁰P to be 2.501(2) min. This agrees with, but is a factor of 2 more precise than, the literature value.

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